

Special Issue

Advanced Neuroimaging Methods in Brain and Neurological Disorders closed

Message from the Guest Editors

This special issue of "Advanced Neuroimaging Methods in Brain and Neurological Disorders" hosted by the guest editors uses the latest and most advanced image processing and image analysis methods to study brain and neurological diseases and conditions. In this special issue, we will invite articles that explore novel problems in brain imaging, requiring these kinds of methods/techniques in the development of computer-aided diagnosis (CAD) systems for the detection of neurological disorders. **Topics are itemized below but are not limited to:**

- Data augmentation methods for learning in medical imaging
- Regularization technology of deep model in small-sample learning in medical imaging
- Ensemble learning based methods in medical imaging
- Neural network based methods in medical imaging
- Meta-learning based methods in medical imaging
- Explainable AI model for classification in medical imaging
- Fine-tuning based methods for classification in medical imaging
- Theoretical analysis for classification in medical imaging
- Transfer learning methods for classification in medical imaging

Guest Editors

Prof. Dr. Juan Manuel Gorriz Saez

Dr. Shuihua Wang

Dr. Roohallah Alizadehsani

Deadline for manuscript submissions

closed (20 June 2023)



Applied Sciences

an Open Access Journal
by MDPI

Impact Factor 2.5
CiteScore 5.5



mdpi.com/si/126618

Applied Sciences
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
appls@mdpi.com

[mdpi.com/journal/
appls](https://mdpi.com/journal/appls)





Applied Sciences

an Open Access Journal
by MDPI

Impact Factor 2.5
CiteScore 5.5



[mdpi.com/journal/
applsci](https://mdpi.com/journal/applsci)



About the Journal

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo
Dipartimento di Fisica, Politecnico di Milano, Piazza L. da Vinci 32,
20133 Milano, Italy

Author Benefits

Open Access:

free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility:

indexed within Scopus, SCIE (Web of Science), Ei Compendex, Inspec, CAPlus / SciFinder, and other databases.

Journal Rank:

JCR - Q2 (Engineering, Multidisciplinary) / CiteScore - Q1 (General Engineering)